TLC272, TLC272A, TLC272B, TLC272Y, TLC277 LinCMOS™ PRECISION DUAL OPERATIONAL AMPLIFIERS

1IN-

GND

1IN+ [

3

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8 V_{DD}

7 20UT

6 2IN-

5 2IN+

NC

D, JG, P, OR PW PACKAGE (TOP VIEW)

• Trimmed Offset Voltage:

TLC277 . . . 500 μ V Max at 25°C, $V_{DD} = 5 \text{ V}$

- Input Offset Voltage Drift . . . Typically
 0.1 μV/Month, Including the First 30 Days
- Wide Range of Supply Voltages Over Specified Temperature Range:

0°C to 70°C ... 3 V to 16 V -40°C to 85°C ... 4 V to 16 V -55°C to 125°C ... 4 V to 16 V

- Single-Supply Operation
- Common-Mode Input Voltage Range Extends Below the Negative Rail (C-Suffix, I-Suffix types)
- Low Noise . . . Typically 25 nV/√Hz at f = 1 kHz
- Output Voltage Range Includes Negative Rail
- High Input impedance . . . 10¹² Ω Typ
- ESD-Protection Circuitry
- Small-Outline Package Option Also Available in Tape and Reel
- Designed-In Latch-Up Immunity

10 11 12 13

NC - No internal connection

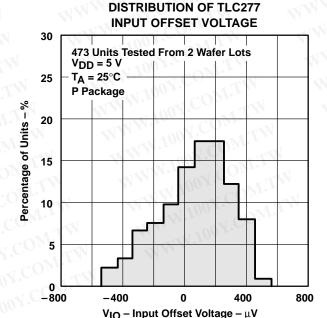
NC

description

The TLC272 and TLC277 precision dual operational amplifiers combine a wide range of input offset voltage grades with low offset voltage drift, high input impedance, low noise, and speeds approaching those of general-purpose BiFET devices.

These devices use Texas Instruments silicongate LinCMOS™ technology, which provides offset voltage stability far exceeding the stability available with conventional metal-gate processes.

The extremely high input impedance, low bias currents, and high slew rates make these cost-effective devices ideal for applications previously reserved for BiFET and NFET products. Four offset voltage grades are available (C-suffix and I-suffix types), ranging from the low-cost TLC272 (10 mV) to the high-precision TLC277 (500 μV). These advantages, in combination with good common-mode rejection and supply voltage rejection, make these devices a good choice for new state-of-the-art designs as well as for upgrading existing designs.



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description (continued)

AVAILABLE OPTIONS

iption (conti	nued)						
WW.1007.	COM.	ZAA ,	AVAILABL	E OPTIONS	T V	WWW.10	onv.COM
W 1 100	Mon	LA	PAC	CKAGED DEVI	CES	WW.	aC0
TA . 100	V _{IO} max AT 25°C	SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (JG)	PLASTIC DIP (P)	TSSOP (PW)	CHIP FORM (Y)
0°C to 70°c	500 μV 2 mV 5 mV 10mV	TLC277CD TLC272BCD TLC272ACD TLC272CD	- 41, - 21,11, - 51,11,	14.1 <u>=</u> 04.0 N.10 0 04.0	TLC277CP TLC272BCP TLC272ACP TLC272CP	 TLC272CPW	— — — TLC272Y
-40°C to 85°C	500 μV 2 mV 5 mV 10 mV	TLC277ID TLC272BID TLC272AID TLC272ID	1 = M	1.11.100 1.11.100 1.11.100	TLC277IP TLC272BIP TLC272AIP TLC272IP	M - 4	M.M.Z. 100

The D package is available taped and reeled. Add R suffix to the device type (e.g., TLC277CDR).

In general, many features associated with bipolar technology are available on LinCMOS™ operational amplifiers without the power penalties of bipolar technology. General applications such as transducer interfacing, analog calculations, amplifier blocks, active filters, and signal buffering are easily designed with the TLC272 and TLC277. The devices also exhibit low voltage single-supply operation, making them ideally suited for remote and inaccessible battery-powered applications. The common-mode input voltage range includes the negative rail.

A wide range of packaging options is available, including small-outline and chip carrier versions for high-density system applications.

The device inputs and outputs are designed to withstand –100-mA surge currents without sustaining latch-up.

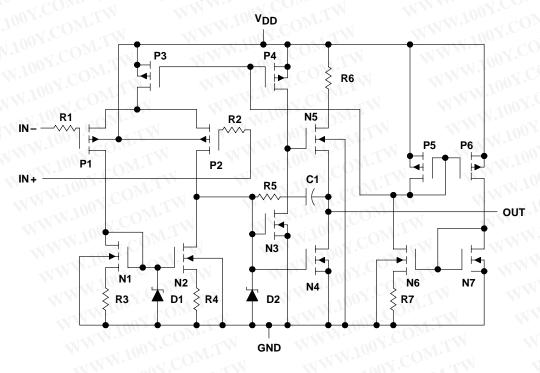
The TLC272 and TLC277 incorporate internal ESD-protection circuits that prevent functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2; however, care should be exercised in handling these devices as exposure to ESD may result in the degradation of the device parametric performance.

The C-suffix devices are characterized for operation from 0°C to 70°C. The I-suffix devices are characterized for operation from -40°C to 85°C. The M-suffix devices are characterized for operation over the full military temperature range of -55°C to 125°C.



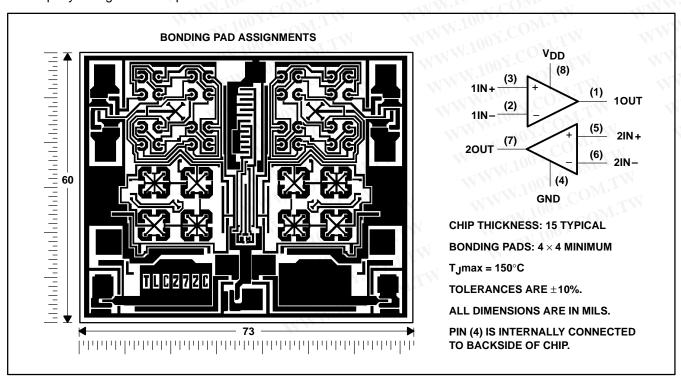
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equivalent schematic (each amplifier)



TLC272Y chip information

This chip, when properly assembled, displays characteristics similar to the TLC272C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{DD} (see Note 1)	18 V
Differential input voltage, V _{ID} (see Note 2)	±V _{DD}
Input voltage range, V _I (any input)	
Input current, I ₁	±5 mA
output current, IO (each output)	±30 mA
Total current into V _{DD}	
Total current out of GND	
Duration of short-circuit current at (or below) 25°C (see Note 3)	unlimited
Continuous total dissipation	
	See Dissipation Rating Table
Continuous total dissipation	See Dissipation Rating Table 0°C to 70°C
Continuous total dissipation	See Dissipation Rating Table0°C to 70°C40°C to 85°C
Continuous total dissipation Operating free-air temperature, T _A : C suffix I suffix M suffix	See Dissipation Rating Table0°C to 70°C40°C to 85°C55°C to 125°C
Continuous total dissipation Operating free-air temperature, T _A : C suffix I suffix	See Dissipation Rating Table0°C to 70°C40°C to 85°C55°C to 125°C65°C to 150°C
Continuous total dissipation Operating free-air temperature, T _A : C suffix I suffix M suffix Storage temperature range	See Dissipation Rating Table0°C to 70°C40°C to 85°C55°C to 125°C65°C to 150°C260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values, except differential voltages, are with respect to network ground.
- Differential voltages are at IN+ with respect to IN –.
 The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded (see application section).

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D	725 mW	5.8 mW/°C	464 mW	377 mW	N/A
FK	1375 mW	11 mW/°C	880 mW	715 mW	275 mW
JG	1050 mW	8.4 mW/°C	672 mW	546 mW	210 mW
Р	1000 mW	8.0 mW/°C	640 mW	520 mW	N/A
PW	525 mW	4.2 mW/°C	336 mW	N/A	N/A

recommended operating conditions

	M.In. COM.	C SU	FFIX	I SUI	FFIX	M SU	FFIX	(N
	W. 1007. COM	MIN	MAX	MIN	MAX	MIN	MAX	UNIT
Supply voltage, V _{DD}	MM. 1100X.CO	3	16	4	16	4	16	V
O	V _{DD} = 5 V	-0.2	3.5	-0.2	3.5	0	3.5	V
Common-mode input voltage, V _{IC}	V _{DD} = 10 V	-0.2	8.5	-0.2	8.5	0	8.5	V
Operating free-air temperature, T _A	W. 100 F.	0	70	-40	85	-55	125	°C
Operating free-air temperature, 1 _A	WWW.100Y.C	COM	.TW	-40	85	-55	125	



TLC272, TLC272A, TLC272B, TLC272Y, TLC277 LinCMOS™ PRECISION DUAL OPERATIONAL AMPLIFIERS

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electrical characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$ (unless otherwise noted)

WW	PARAMETER	W.	TEST COND	ITIONS	_{TA} †	TLC272	C, TLC2 BC, TL		UNIT
			W.1001.		7	MIN	TYP	MAX	
W	TIME TO THE TANK		V _O = 1.4 V,	V _{IC} = 0,	25°C	-WXI 1	1.1	10	TAL
		TLC272C	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	M 4.	1007.	12	TW
		TI 007040	V _O = 1.4 V,	V _{IC} = 0,	25°C	MAN.	0.9	5	mV
	N V 100Y.	TLC272AC	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	-TVN V	The	6.5	
VIO	Input offset voltage	7	V _O = 1.4 V,	$V_{IC} = 0$,	25°C	W.	230	2000	$M_{i,I}$
		TLC272BC	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	MM	-110	3000	~ 1.1
		TI 00770	$V_{O} = 1.4 \text{ V},$	$V_{IC} = 0$,	25°C	WV	200	500	μV
		TLC277C	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	- 1	WW.	1500	
α_{VIO}	Temperature coefficient of inp	out offset voltage	MAN.10	ON COM	25°C to 70°C	1	1.8	700,	μV/°C
	V 1003	COMIT		100 -1 CO	25°C		0.1	60	V CC
ΙΟ	Input offset current (see Note	4)	N V	1007.	70°C		7	300	pA
	WWW.	CO	$V_0 = 2.5 \text{ V},$	$V_{IC} = 2.5 V$	25°C		0.6	60	00 x
lΒ	Input bias current (see Note 4	t) COM	Ww W		70°C		40	600	pA
	Common-mode input voltage	range	W WW	WW.100Y	25°C	-0.2 to 4	-0.3 to 4.2	MAN	17A)
VICR	(see Note 5)	100X.COM	LTW V		Full range	-0.2 to 3.5		WW	V
	Mari	V 100 7.	N_{i,I,A_i}	W.11	25°C	3.2	3.8	- 44	
V_{OH}	High-level output voltage		$V_{ID} = 100 \text{ mV},$	$R_L = 10 \text{ k}\Omega$	0°C	3	3.8	1//	V
	Www		OWE	MWW.	70°C	3	3.8		
	1	M. Joo	OM	WWI	25°C	O_{Mr} .	0	50	
VOL	Low-level output voltage		$V_{ID} = -100 \text{ mV},$	$I_{OL} = 0$	0°C	$\sim 0 M_{\odot}$	0	50	mV
			VILIV		70°C	Mo.	0	50	
		MMM	COM	WV	25°C	5	23		W
A_{VD}	Large-signal differential voltage	ge amplification	$V_0 = 0.25 \text{ V to 2 V},$	$R_L = 10 \text{ k}\Omega$	0°C	(4)	27	N	V/mV
			Dr. COMITW		70°C	4	20	_ 1	
		WW	WI.M.		25°C	65	80	AA	
CMRR	Common-mode rejection ratio	MMM.,	V _{IC} = V _{ICR} min		0°C	60	84	TW	dB
		TAN W	COM	N.	70°C	60	85	W	
		NA TATA	100 r. COM.	-1	25°C	65	95	1.1	1
ksvr	Supply-voltage rejection ratio (ΔVDD/ΔVIO)		$V_{DD} = 5 \text{ V to } 10 \text{ V},$	$V_0 = 1.4 \text{ V}$	0°C	60	94	M.T.V	dB
	(DD/ * IO/	WW	M. COM.	TW	70°C	60	96	TIL	N
			M. LO		25°C	W.F	1.4	3.2	
I_{DD}	Supply current (two amplifiers	s)	V _O = 2.5 V, No load	$V_{IC} = 2.5 V,$	0°C	WW.M	1.6	3.6	mA
			140 1000		70°C		1.2	2.6	

† Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

1	PARAMETER	LA A	TEST CONDI	TIONS	T _A †	TLC272 TLC272			UNIT
			W.1001.		1	MIN	TYP	MAX	W.r.
	MM. 1007.00	1 CO700	$V_0 = 1.4 \text{ V},$	V _{IC} = 0,	25°C	11	1.1	10	$^{OM_{i,j}}$
		TLC272C	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	MM	11	12	المت
		TI C070AC	$V_0 = 1.4 \text{ V},$	$V_{IC} = 0$,	25°C	WV	0.9	5	mV
V	lanut affact Milana	TLC272AC	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range		WW.	6.5	CON
V _{IO}	Input offset voltage	TI 0070D0	V _O = 1.4 V,	V _{IC} = 0,	25°C		290	2000	. <0
		TLC272BC	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	1	MAN.	3000	1.00
		CQ TI 00770	$V_0 = 1.4 \text{ V},$	$V_{IC} = 0$,	25°C		250	800	μV
	M., 100 x	TLC277C	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			1900	. √ (
α_{VIO}	Temperature coefficient of in	put offset voltage	WW WW	N.100 X.	25°C to 70°C	N	2	WW.	μV/°C
		COM		Wille	25°C	CN .	0.1	60	70
ΙΟ	Input offset current (see Not	e 4)		N.100 X	70°C		7	300	pA
	MM	"UUA''CO	$V_0 = 5 V$,	$V_{IC} = 5 V$	25°C	LN.	0.7	60	or 1.00
lΒ	Input bias current (see Note	4) COM			70°C	TW	50	600	pΑ
	Common-mode input voltage	e range	M.TW	WWW.IO	25°C	-0.2 to 9	-0.3 to 9.2	W	V
VICR	(see Note 5)	AM:100X:C	OM.TW		Full range	-0.2 to 8.5	W	, , , , , , , , , , , , , , , , , , ,	٧
	W	1007.	JON:IN	NV -	25°C	- 8	8.5		
۷он	High-level output voltage		$V_{ID} = 100 \text{ mV},$	$R_L = 10 \text{ k}\Omega$	0°C	7.8	8.5		٧
			COM		70°C	7.8	8.4		W
		1. IN. 100	COM.		25°C	CO)	0	50	11
VOL	Low-level output voltage		$V_{ID} = -100 \text{ mV},$	$I_{OL} = 0$	0°C	- CC	0	50	mV
			OY.COTITY		70°C	101.	0	50	4
		MMM.	ON COM	N	25°C	10	36	TW	
AVD	Large-signal differential volta	age amplification	$V_0 = 1 \text{ V to 6 V},$	R _L = 10 kΩ	0°C	7.5	42	TW	V/mV
		WY	1001. OM.	AA	70°C	7.5	32	1.1	ī
		MM	1100X.	TW	25°C	65	85	M.T.	V
CMRR	Common-mode rejection rati	io WW	V _{IC} = V _{ICR} min		0°C	60	88	11	√dB
			W.Ing COJ	1.1	70°C	60	88	OMr.	CVI
		44.	W.100 1.	William	25°C	65	95	·OM·	1
ksvr	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})		$V_{DD} = 5 \text{ V to } 10 \text{ V},$	V _O = 1.4 V	0°C	60	94		dB
	(¬,DD,¬,D)		WW. LON.C	Oly LAN	70°C <	60	96	Co	WTI
			TINN TOO	OM	25°C	NW	1.9	(C4)	N. T.
IDD	Supply current (two amplifier	rs)	V _O = 5 V, No load	$V_{IC} = 5 V$	0°C	TAX!	2.3	4.4	mA
			INO IOAU		70°C	MA	1.6	3.4	

[†]Full range is 0°C to 70°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

WW	PARAMETER	WA	TEST COND	ITIONS	T _A †		2I, TLC2 2BI, TL		UNIT
			W.1001.			MIN	TYP	MAX	- 1
W	TOOY.CO TITY		V _O = 1.4 V,	V _{IC} = 0,	25°C	-XXI 1	1.1	10	IA
		TLC272I	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	Mari	1007	13	WIT
			V _O = 1.4 V,	V _{IC} = 0,	25°C	JWW.	0.9	5	mV
	N V 100Y.	TLC272AI	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	-TXXIV	Too	7 (7)	M_{TT}
V _{IO}	Input offset voltage	TN	V _O = 1.4 V,	V _{IC} = 0,	25°C	M. A.	230	2000	M.I
		TLC272BI	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	MAN	-110	3500	-3.1
		VI.	V _O = 1.4 V,	$V_{IC} = 0$,	25°C	WV	200	500	μV
		TLC2771	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	-1	WW.	2000	COM
α_{VIO}	Temperature coefficient of inp	out offset voltage	WWW.1	ON COM	25°C to 85°C		1.8	100	μV/°C
	7, 100	COMIT	W.W.	100 -1 CO	25°C		0.1	60	S CC
ΙO	Input offset current (see Note	: 4)	MAN		85°C		24	15	pA
	WWW	CON TY	$V_0 = 2.5 \text{ V},$	$V_{IC} = 2.5 V$	25°C		0.6	60	10 J.
lΒ	Input bias current (see Note	4) COM-	WW.		85°C		200	35	pA
	Common-mode input voltage	range COM.	W WY	M.100X	25°C	-0.2 to	-0.3 to 4.2	MAN	(.1V)
VICR	(see Note 5)	100X.COM	TW V		Full range	-0.2 to 3.5		WW	V
	77	N.100 CO	W.L.	W.W.I	25°C	3.2	3.8	- 1	
Vон	High-level output voltage		$V_{ID} = 100 \text{ mV},$	$R_L = 10 \text{ k}\Omega$	-40°C	3	3.8	- W	V
	WW		UT.	MM M.	85°C	3	3.8		AM
		NW.IO	OM	WW	25°C	OME	0	50	WW
V_{OL}	Low-level output voltage		$V_{ID} = -100 \text{ mV},$	$I_{OL} = 0$	-40°C	-0M.	0	50	mV
-			MITH	1	85°C		0	50	771
		MANA	CO TW	WW	25°C	5	23		11
A_{VD}	Large-signal differential voltage	ge amplification	$V_{O} = 1 \text{ V to 6 V,}$	R _L = 10 kΩ	-40°C	3.5	32	N	V/mV
			COWITY	= 11	85°C	3.5	19	-31	
		MAI 1	ON.TW	V	25°C	65	80	A	
CMRR	Common-mode rejection ratio	MMM.,	V _{IC} = V _{ICR} min		-40°C	60	81	TW	dB
	•		COM		85°C	60	86	TW.	
		- 17	Jan . COM.	- 41	25°C	65	95	1.2	I
ksvr	Supply-voltage rejection ratio		$V_{DD} = 5 \text{ V to } 10 \text{ V},$	V _O = 1.4 V	-40°C	60	92	$M_{1,1,1}$	dB
	$(\Delta V_{DD}/\Delta V_{IO})$		M. Z	WT	85°C	60	96	Time	
		-31	M. LOD	TIN	25°C	M	1.4	3.2	
I _{DD}	Supply current (two amplifiers	s)	$V_O = 2.5 \text{ V},$	$V_{IC} = 2.5 V$,	-40°C	M.10	1.9	4.4	mA
		W	No load		85°C		1.1	2.4	

[†] Full range is –40°C to 85°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

V	PARAMETER	TW	TEST COND	TIONS	T _A †	TLC27	2I, TLC2 2BI, TL		UNIT
			W.1001.		, ^	MIN	TYP	MAX	W.r.
	MM. 100X.Co	M. 7 . 00701	V _O = 1.4 V,	V _{IC} = 0,	25°C	1	1.1	10	$M_{i,I}$
		TLC272I	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	MM	-11	13	-31
		TI 0070AI	$V_0 = 1.4 \text{ V},$	$V_{IC} = 0$,	25°C	WV	0.9	5	mV
V	The state of the s	TLC272AI	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	- 1	WW.	7	CON
V _{IO}	Input offset voltage	TI 0070DI	V _O = 1.4 V,	V _{IC} = 0,	25°C	14	290	2000	
		TLC272BI	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	1	MAN.	3500	1.00
		TI 00771	$V_0 = 1.4 \text{ V},$	$V_{IC} = 0$,	25°C		250	800	μV
	W . 100	TLC277I	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range			2900	~<1 C
α_{VIO}	Temperature coefficient of	input offset voltage	WW.	N.1007.	25°C to 85°C	Ī	2	WW.	μV/°C
	Lament of the standard of the	a A COM.		M.Ino	25°C	(X)	0.1	60	, To
lο	Input offset current (see No	ote 4)	, -, m	100 x	85°C		26	1000	pA
	MM	TOON.CO	$V_0 = 5 V$,	$V_{IC} = 5 V$	25°C	CAN.	0.7	60	osi 1.00
lΒ	Input bias current (see Not	e 4)	TW V		85°C	TW	220	2000	pΑ
	VI TON	W.100		AMM To	ost CON	-0.2	-0.3	11/	Mir
			W.TW		25°C	to	to		V
V _{ICR}	Common-mode input voltage	ge range	WILL		001.CO	9	9.2	V	11.
1011	(see Note 5)	Note 5)		Full range	-0.2 to			V	
			$O_{M^{-1}}$		Tull lange	8.5			WW
		A. 100x.	COMITM		25°C	8	8.5		-11/
Vон	High-level output voltage		$V_{ID} = 100 \text{ mV},$	$R_L = 10 \text{ k}\Omega$	-40°C	7.8	8.5		V
0			C.CUPT TW	- WV	85°C	7.8	8.5		W
		INN. Ion	Z COM.	- T	25°C	A.CO	0	50	11
V_{OL}	Low-level output voltage		$V_{ID} = -100 \text{ mV},$	$I_{OL} = 0$	-40°C	-100	0	50	mV
<u> </u>			ON.TV	V-	85°C	01.	0	50	
		MMA	ONY.CO	N	25°C	10	36	TW	
AVD	Large-signal differential vol	tage amplification	$V_0 = 1 \text{ V to 6 V},$	R _L = 10 kΩ	-40°C	7	46	TW	V/mV
-		WITT	100 r. COM.	T 4.	85°C	7	31	1	J
		W	1100Y.	IM	25°C	65	85	MI	*
CMRR	Common-mode rejection ra	atio W	V _{IC} = V _{ICR} min		-40°C	60	87	Time	dB
		XIV	M. To COL	TW	85°C	60	88	Oh	W
			M.100 . CO	Mil	25°C	65	95	$^{2}O_{Mr}$	-XXI
ksvr	Supply-voltage rejection ra (ΔVDD/ΔVIO)	atio	$V_{DD} = 5 \text{ V to } 10 \text{ V},$	V _O = 1.4 V	-40°C	60	92	CON	dB
	(σ.Δ.Π.) (σ.Δ.Π.)		IN W. TOON'C	WT	85°C √	60	96		TY
			WW.	Olar	25°C	MANA	1.4	4	
I _{DD}	Supply current (two amplifi	ers)	V _O = 5 V, No load	$V_{IC} = 5 V$	-40°C	TIN	2.8	5	mA
			INO IDAU		85°C	44.	1.5	3.2	

[†]Full range is -40°C to 85°C.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



^{5.} This range also applies to each input individually.

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electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

	PARAMETER		TEST COND	ITIONS	T _A †	TLC27	2M, TLC	277M	UNIT
WIN	PARAMETER	WV	TEST COND	ITIONS	'A'	MIN	TYP	MAX	UNIT
	W.100 COM.	LC272M	V _O = 1.4 V,	$V_{IC} = 0$,	25°C	111.1	1.1	10	mV
V _{IO}	Input offset voltage	LOZ/ZIVI	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	$\propto 1 \text{ N} \cdot 1$	UU -	12	IIIV
VIO		LC277M	$V_0 = 1.4 V$,	$V_{IC} = 0$,	25°C	N N	200	500	μV
<	MAN CO.		$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range		400	3750	μν
ανιο	Temperature coefficient of input offs voltage	et	WWW.IOOY	.COM.TY	25°C to 125°C	WWV	2.1	Y.CU	μV/°C
	land offers authors (see Nictor)		11/1/1/1/100	Y.C. 11	25°C	17	0.1	60	pA
lio	Input offset current (see Note 4)	«N	V- 05V	V.COM	125°C	WV	1.4	15	nA
	Land Backling Co. No. OM. I	-7	$V_0 = 2.5 \text{ V}$	$V_{IC} = 2.5 V$	25°C	- X T	0.6	60	pA
lΒ	Input bias current (see Note 4)		WWW.		125°C	- 11	9	35	nA
V:	Common-mode input voltage range	I.TW WT.N	MMM	100X.CO	25°C	0 to 4	-0.3 to 4.2	N.100	V
VICR	(see Note 5)		N WW		Full range	0 to 3.5	MA	X X X	V
	WWW. COV.C	Obr	VVV VV	144.	25°C	3.2	3.8	MA	1005
Vон	High-level output voltage		V _{ID} = 100 mV,	$R_L = 10 \text{ k}\Omega$	−55°C	3	3.8		٧
			In		125°C	3	3.8	-730	W.10
	WW 1005	1.00	TW	100	25°C	IM	0	50	-xx/10
V_{OL}	Low-level output voltage		$V_{ID} = -100 \text{ mV},$	$I_{OL} = 0$	−55°C	WT	0	50	mV
	WW.100	T CC	M. I	WW.I	125°C	VI.	0	50	
	W	00 7.	$o_{M:I_{A_{A_{A}}}}$	W.	25°C	5	23		TAV
AVD	Large-signal differential voltage amp	olification	$V_0 = 0.25 \text{ V to 2 V}$	$R_L = 10 \text{ k}\Omega$	−55°C	3.5	35		V/mV
	MMM.	. No.	COMP	MMA	125°C	3.5	16		
	WW	Too	COM	WW	25°C	65	80		WW
CMRR	Common-mode rejection ratio		$V_{IC} = V_{ICR}min$		−55°C	60	81		dB
	Mu.	100	I.C.		125°C	60	84		
	WW	M.	N.CO. TW	W	25°C	65	95	N	T.
SVR	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})		$V_{DD} = 5 \text{ V to } 10 \text{ V},$	V _O = 1.4 V	−55°C	60	90	N	dB
	(3,00,3,10)	TXV.1	Mr. COMITA	1	125°C	60	97	-\$1	
	1/2	NV TAT	1007.	V 0.511	25°C	001.	1.4	3.2	
I_{DD}	Supply current (two amplifiers)		V _O = 2.5 V, No load	$V_{IC} = 2.5 V,$	−55°C	1001	2	5	mA
			COM		125°C	7	CH	2.2	J

[†] Full range is -55°C to 125°C.

WWW.100Y.COM.TW NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually. WWW.100Y.COM.TW



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electrical characteristics at specified free-air temperature, V_{DD} = 10 V (unless otherwise noted)

W	W TO A SOLINETTE TO	N .	TEAT	ITIONIO.	T. +	TLC27	2M, TLC	277M	1.7.
	PARAMETER		TEST CONE	ITIONS	T _A †	MIN	TYP	MAX	UNIT
	M. Inn COM.	TI 007014	V _O = 1.4 V,	$V_{IC} = 0$,	25°C	WW	1.1	10	Mr.
v	MAN WATER OF THE STATE OF THE S	TLC272M	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range	- 11	M.10	12	mV
V_{IO}	Input offset voltage	TI 007714	$V_0 = 1.4 V$,	V _{IC} = 0,	25°C	41.	250	800	Mo
		TLC277M	$R_S = 50 \Omega$,	$R_L = 10 \text{ k}\Omega$	Full range		1	4300	μV
αΛΙΟ	Temperature coefficient of inp voltage	out offset	WWW.	100 Y.COM	25°C to 125°C	W	2.2	17007	μV/°C
	WWW.	On-	M.M.	OUXICO	25°C		0.1	60	pA
I _{IO}	Input offset current (see Note	4)		1.700 ×1.CO	125°C		1.8	15	nA
	W. 100 r.	"COM.II"	$V_0 = 5 V$,	V _{IC} = 5 V	25°C		0.7	60	pA
ΙΒ	Input bias current (see Note 4	1)	N Alm		125°C		10	35	nA
	Common-mode input voltage	range	M MA	WW.100Y.	25°C	0 to 9	-0.3 to 9.2	MM	100x
VICR	(see Note 5)	OOX.COM	TW V		Full range	0 to 8.5	4	MM	N \$00
	WW	100 CO	NI.	WWW.I	25°C	8	8.5		MA.
Vон	High-level output voltage		$V_{ID} = 100 \text{ mV},$	$R_L = 10 \text{ k}\Omega$	−55°C	7.8	8.5		V
			WIIM		125°C	7.8	8.4	V	
	WW	VI.	TW	MM	25°C	- N T	0	50	144
V_{OL}	Low-level output voltage		$V_{1D} = -100 \text{ mV},$	$I_{OL} = 0$	−55°C	Obs	0	50	mV
			COM.I		125°C	CO_{MT} .	0	50	TAT V
	· · · · · · · · · · · · · · · · · · ·	100	I.OM.TW	1111	25°C	10	36	4	41
AVD	Large-signal differential voltage amplification	ge	$V_0 = 1 \ V \text{ to 6 V},$	$R_L = 10 \text{ k}\Omega$	−55°C	7	50		V/mV
	ampilioation		ON COM.		125°C	(C7)	27	N	17
		TATANA	in COM'r.	×1	25°C	65	85	XX	
CMRR	Common-mode rejection ratio	MM	V _{IC} = V _{ICR} min		−55°C	60	87		dB
			TOUX COL		125°C	60	86	TW	
		WWW	· r COM	σW	25°C	65	95	WT	
ksvr	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})		$V_{DD} = 5 \text{ V to } 10 \text{ V},$	V _O = 1.4 V	−55°C	60	90	1.	_ dB
	(\article \DD\article \OU)		W 100 Y.	V.T.M	125°C	60	97	M_{-1}	-1
		W	1001.Co.	WTIL	25°C	100	1.9	4	M
IDD	Supply current (two amplifiers	s)	V _O = 5 V, No load	$V_{IC} = 5 V$	−55°C	14.5	3	6	mA
			INO IOAU		125°C	111.11	1.3	2.8	- 1

[†] Full range is -55°C to 125°C.

WWW.100Y.COM.TW NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.



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electrical characteristics, V_{DD} = 5 V, T_A = 25°C (unless otherwise noted)

MM.	100Y.C - 5TM - 100	7507.00	DITIONS	100 T	LC272Y	T.T.	
	PARAMETER	TEST CONI	DITIONS	MIN	TYP	MAX	UNIT
V _{IO}	Input offset voltage	$V_{O} = 1.4 \text{ V},$ $R_{S} = 50 \Omega,$	$V_{IC} = 0,$ $R_L = 10 \text{ k}\Omega$	WW.IC	001.1 ^C	10	mV
ανιο	Temperature coefficient of input offset voltage	ONY.CO	W W	NN T	1.8		μV/°C
lio	Input offset current (see Note 4)	· COM	N 051/	A NA	0.1	(Co.	pA
I _{IB}	Input bias current (see Note 4)	$V_0 = 2.5 \text{ V},$	$V_{IC} = 2.5 V$	TINV	0.6	<√ CO	pA
VICR	Common-mode input voltage range (see Note 5)	14.100X.COM	N.T.W	-0.2 to 4	-0.3 to 4.2	oy.C	OW.
Vон	High-level output voltage	V _{ID} = 100 mV,	R _L = 10 kΩ	3.2	3.8	00x.	V
VOL	Low-level output voltage	$V_{ID} = -100 \text{ mV},$	I _{OL} = 0	W	0	50	mV
AVD	Large-signal differential voltage amplification	V _O = 0.25 V to 2 V	$R_L = 10 \text{ k}\Omega$	5	23		V/mV
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICR} min	OM	65	80	V.Inc	dB
ksvr	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	$V_{DD} = 5 \text{ V to } 10 \text{ V},$	V _O = 1.4 V	65	95	W.10	dB
I _{DD}	Supply current (two amplifiers)	V _O = 2.5 V, No load	$V_{IC} = 2.5 \text{ V},$	N.	1.4	3.2	mA

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually.

electrical characteristics, V_{DD} = 10 V, T_A = 25°C (unless otherwise noted)

		TEST SON	DITIONS	I III	LC272Y		-4×1 10
	PARAMETER	TEST CON	DITIONS	MIN	TYP	MAX	UNIT
V _{IO}	Input offset voltage	$V_{O} = 1.4 \text{ V},$ $R_{S} = 50 \Omega,$	$V_{IC} = 0,$ $R_L = 10 \text{ k}\Omega$	MIT	1.1	10	mV
α_{VIO}	Temperature coefficient of input offset voltage	TW WW	100X.C	Time	1.8		μV/°C
lιο	Input offset current (see Note 4)	- W - W	N.V NOV.	OF.	0.1		pA
I _{IB}	Input bias current (see Note 4)	$V_O = 5 V$	$V_{IC} = 5 V$	$\mathbb{C}O_{M_{P}}$.	0.7		pA
VICR	Common-mode input voltage range (see Note 5)	ONITW Y	MMM.100.	-0.2 to 9	-0.3 to 9.2	×1	٧
Vон	High-level output voltage	$V_{ID} = 100 \text{ mV},$	$R_L = 10 \text{ k}\Omega$	8	8.5		V
V_{OL}	Low-level output voltage	$V_{ID} = -100 \text{ mV},$	IOL = 0	101	0	50	mV
AVD	Large-signal differential voltage amplification	$V_0 = 1 \text{ V to 6 V},$	$R_L = 10 \text{ k}\Omega$	10	36	TW	V/mV
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICR} min	WW.	65	85	~11	dB
ksvr	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	$V_{DD} = 5 \text{ V to } 10 \text{ V},$	V _O = 1.4 V	65	95	1.1.	dB
I _{DD}	Supply current (two amplifiers)	V _O = 5 V, No load	V _{IC} = 5 V,	W.1003	1.9	4	mA

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

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operating characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

V	PARAMETER	TEST CO	NDITIONS	TA	TLC272C, TLC272BC		
		W 1 100 x	COM.TV	, ^	MIN T	YP MAX	
	WWW.	1100	T.IV	25°C	MAI	3.6	T.Mo.
		WWW.	V _{IPP} = 1 V	√ 0°C	MM	4	
0.0	Clausett Musika sala COM	$R_L = 10 \text{ k}\Omega$	COM.	70°C	WW	3	COM
SR Slew r	Slew rate at unity gain	C _L = 20 pF, See Figure 1	V _{IPP} = 2.5 V	25°C	- TXX	2.9	V/μs
		Coo riguro r		0°C	11.	3.1	7.00
		MMW.	OUN.COP	70°C	W	2.5	N.Co.
Vn	Equivalent input noise voltage	f = 1 kHz, See Figure 2	$R_S = 20 \Omega$,	25°C	V	25	nV/√Hz
	MAIN. ON CO.	M MM	TOON CO	25°C	1	320	1001
ВОМ	Maximum output-swing bandwidth	V _O = V _{OH} ,	C _L = 20 pF, See Figure 1	0°C		340	kHz
		$R_L = 10 \text{ k}\Omega$		70°C		260	100
	WW. 2100X.C	(III)	1007	25°C	1.	1.7	0.100
В1	Unity-gain bandwidth	V _I = 10 mV, See Figure 3	C _L = 20 pF,	0°C		2	MHz
•		See Figure 3	WWW.loo	70°C	TW	1.3	111.
	W.100 -	Mir	A. Too	25°C	N.	46°	MAN
φm	Phase margin	$V_{I} = 10 \text{ mV},$ $C_{I} = 20 \text{ pF},$	f = B ₁ , See Figure 3	0°C	M.I.	47°	TAIN!
		CL = 20 pr,	See rigule 3	70°C	WILL	43°	A NA A

operating characteristics at specified free-air temperature, V_{DD} = 10 V

	PARAMETER	TEST CO	NDITIONS	TAO	TLC272C, TLC272AC, TLC272BC, TLC277C		UNIT	
		COMP	WW	11.7.	MIN	TYP	MAX	W
	V	"OM"		25°C	· · · · · · · · · · · · · · · · · · ·	5.3	≪ 1	
		I.V	V _{IPP} = 1 V	0°C	11.	5.9	A.	
	MAM	$R_L = 10 \text{ k}\Omega$	W W	70°C	COY.C.	4.3		\ \ <i>\</i> ''
SR	Slew rate at unity gain	C _L = 20 pF, See Figure 1	V _{IPP} = 5.5 V	25°C	~~~ C	4.6	TW	V/µs
		occ rigare r		0°C	100	5.1	. 1	1
		ON.COM		70°C	1 100 r.	3.8	V.I.A.	1
/ _n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	$R_S = 20 \Omega$,	25°C	W.100	25	M.T	nV/√ Hz
	Mari	1001.	Wilm	25°C	- W.100	200	oM_{ij}	
ВОМ	Maximum output-swing bandwidth	V _O = V _{OH} ,	C _L = 20 pF,	0°C	111	220	110	kHz
•		$R_L = 10 \text{ k}\Omega$	See Figure 1	70°C	MAN	140		W
	71	W. Too		25°C	WW.	2.2	$CO_{\tilde{D}}$	
31	Unity-gain bandwidth	V _I = 10 mV, See Figure 3		0°C	W. T.	2.5	- c0	MHz
		See Figure 3	.CO. TY	70°C	MAL	1.8	1.0	
		MW.	V.COP	√ 25°C	WW	49°		
m	Phase margin	$V_{\parallel} = 10 \text{ mV},$ $C_{\parallel} = 20 \text{ pF},$	f = B ₁ , See Figure 3	0°C		50°		
		о_ = 20 рг,	See rigure 3	70°C		46°		

TLC272, TLC272A, TLC272B, TLC272Y, TLC277 LinCMOS™ PRECISION DUAL OPERATIONAL AMPLIFIERS

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operating characteristics at specified free-air temperature, V_{DD} = 5 V

WW	PARAMETER	TEST CO	NDITIONS	TA	TLC272I, TLC272AI, TLC272BI, TLC277I			UNIT
11 1		V.100 1.	M_{II}	41	MIN	TYP	MAX	- 1
W	WITH WITH	11001.	TITI	25°C	-xx 1	3.6	Mos	1.44
4.1		W. CON.C	V _{IPP} = 1 V	-40°C	M. A.	4.5		WT
SR	OM:100 S. COM:1	$R_L = 10 \text{ k}\Omega$		85°C	WW.	2.8	1 . $^{CO_{1}}$	WW
	Slew rate at unity gain	C _L = 20 pF, See Figure 1	V _{IPP} = 2.5 V	25°C	- TANIV	2.9	-1 CO	V/μs
				−40°C	W.	3.5	1.	M^{T}
	WWW.Io. COM.		Y.COM	√ 85°C	MM	2.3	OY.C	-317
V _n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	$R_S = 20 \Omega$,	25°C	WV	25	00Y.	nV/√ Hz
	MAN. SON. COM. TW	$V_O = V_{OH}$, $R_L = 10 \text{ k}\Omega$,	OUX.CO.	25°C	W	320	1007	
Вом	Maximum output-swing bandwidth		C _L = 20 pF, See Figure 1	-40°C		380	. 00	kHz
			See Figure 1	85°C		250	N'Inc	T CO
	MAN, 1100X'C TILL	1/1/1/	C _L = 20 pF,	25°C		1.7	XV.10	0 y.
В1	Unity-gain bandwidth	V _I = 10 mV, See Figure 3		-40°C		2.6	×11	MHz
		See Figure 3	W.M.C	85°C	N	1.2	MAN	
	M. T.M. Ton P. COM. I.		V.V. 100	25°C	- 1	46°	WW	In
φm	Phase margin	$V_{I} = 10 \text{ mV},$ $C_{L} = 20 \text{ pF},$	f = B ₁ , See Figure 3	-40°C		49°	-111	1.100 x
		ο _L = 20 μ,	occ rigure 3	85°C		43°	MA.	100

operating characteristics at specified free-air temperature, V_{DD} = 10 V

	PARAMETER	TEST CO	T _A CO	TLC272I, TLC272AI, TLC272BI, TLC277I			UNIT	
		N. Z.	WWW.	V.C	MIN	TYP	MAX	UNIN
	W. 2N.100 1.	J.T.	With	25°C	OMIL	5.3		-TXN
		WIIM	V _{IPP} = 1 V	-40°C	Mo	6.8		M. A.
00	WWW.	$R_L = 10 \text{ k}\Omega$	WW	85°C	.00	4		WW
SR	Slew rate at unity gain	C _L = 20 pF, See Figure 1	V _{IPP} = 5.5 V	25°C	$^{1}CO_{Ia}$	4.6		V/µs
				-40°C	CO	5.8	≪ 1	
			W.	85°C	M.	3.5	MA	
٧n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	$R_S = 20 \Omega$,	25°C	OXICE	25	TV T	nV/√Hz
	1100	JA. ONL.	14	25°C	100 1.	200	LA	
Вом	Maximum output-swing bandwidth	V _O = V _{OH} ,	C _L = 20 pF, See Figure 1	-40°C	100Y.	260	TW	kHz
•		$R_L = 10 \text{ k}\Omega$	See Figure 1	85°C	001	130	TV	N
	TW.	In CON	1.1	25°C	N'Inc.	2.2	Mr.	MHz
В1	Unity-gain bandwidth	$V_I = 10 \text{ mV},$	$C_L = 20 pF$,	-40°C	W.100	3.1	Mil	
		See Figure 3	WT	85°C	-110	1.7		
	TW.	W. Po	JAN.	25°C	M.	49°		
φm	Phase margin	$V_{I} = 10 \text{ mV},$	f = B ₁ ,	-40°C		52°		
	W	$C_L = 20 pF,$	See Figure 3	85°C		46°		1

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operating characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

V	W. O. Co	1007:	TW		TLC27	2M, TLC	277M	V.J.
	PARAMETER	TEST CO	NDITIONS	TA	MIN	TYP	MAX	UNIT
	1. 100 COM.	M.Inc	COM	25°C	WW	3.6	~ CC	Mr.
		M. 100.	V _{IPP} = 1 V	−55°C	-33	4.7	-1 (OM_{T}
SR	NWW.	$R_L = 10 \text{ k}\Omega$	T L	125°C	1/1/4	2.3	10 A.	.o.M.T
	Slew rate at unity gain	C _L = 20 pF, See Figure 1	V _{IPP} = 2.5 V	25°C	W	2.9	onY.	V/μs
		200 Tigulo T		−55°C	XX	3.7	001	CO_{MT}
			100 y	125°C		2	700.	COD
Vn	Equivalent input noise voltage	f = 1 kHz, See Figure 2	$R_S = 20 \Omega$,	25°C		25	N.100	nV/√ Hz
	M. 1001. CONT. 1.	41	N.100	25°C	r	320	M'In	-<1 C
Вом	Maximum output-swing bandwidth	$V_O = V_{OH}$, $R_L = 10 \text{ k}\Omega$,	C _L = 20 pF, See Figure 1	−55°C		400	-TXV.1	kHz
			occ riguic r	125°C		230	VV 1	1007.
	MAN TO COM	TO U	NW.	25°C		1.7	MA	You
В1	Unity-gain bandwidth	V _I = 10 mV, See Figure 3	$C_L = 20 pF$,	-55°C	-31	2.9	TIN V	MHz
		See Figure 3	100	125°C	11.	1.1	/V '	
	MAM. OUN.CO.	T	MM 1 100	25°C	TW	46°	MAA	-1110
φm	Phase margin	$V_{I} = 10 \text{ mV},$ $C_{I} = 20 \text{ pF},$	f = B ₁ , See Figure 3	-55°C	W	49°	W	1111.
		OL = 20 pr,	Coor iguid 3	125°C	Mr.	41°		WW.1

operating characteristics at specified free-air temperature, V_{DD} = 10 V

		TYN- 00	ND TIEND	A ANY	TLC272M, TLC277M			MAA
	PARAMETER	TEST CO	NDITIONS	TA	MIN	TYP	MAX	UNIT
	W 1003	. OWITH	W.	25°C	CON	5.3	ſ	4
		Y.Co.	V _{IPP} = 1 V	−55°C		7.1		
00	NWW.10	$R_L = 10 \text{ k}\Omega$	W	125°C	N.Co	3.1	N	V/μs
SR	Slew rate at unity gain	C _L = 20 pF, See Figure 1	V _{IPP} = 5.5 V	25°C	ov.CC	4.6	W	
		1000 1 19410 1		−55°C	10-	6.1	-41	
	WWW	100 X.C		125°C	1007.	2.7	1.14	
٧n	Equivalent input noise voltage	f = 1 kHz, See Figure 2	$R_S = 20 \Omega$,	25°C	1.100 X	25	LTW	nV/√H:
ВОМ	Was	11007.	LTW	25°C	W 100	200	$M_{1,1}$	
	Maximum output-swing bandwidth	V _O = V _{OH} ,	C _L = 20 pF,	−55°C	-1100	280	~17	kHz
		$R_L = 10 \text{ k}\Omega$	See Figure 1	125°C	111.	110	Ober	
	Unity-gain bandwidth	M.100	OM.	25°C	MM^{-1}	2.2	OM	-XX
B ₁		V _I = 10 mV, See Figure 3	$C_L = 20 pF$,	−55°C	-TXN .1	3.4	~ON	MHz
		See Figure 3		125°C	A.	1.6		MTN
		N. W. P.	COM	25°C	MANAN	49°	V.CU	
φm	Phase margin	$V_{l} = 10 \text{ mV},$ $C_{L} = 20 \text{ pF},$	f = B ₁ , See Figure 3	_55°C	-TAN'	52°		
	· ·	OL = 20 μι,	See Figure 3	125°C	A4 .	44°		1

TLC272, TLC272A, TLC272B, TLC272Y, TLC277 LINCMOS™ PRECISION DUAL OPERATIONAL AMPLIFIERS

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operating characteristics, V_{DD} = 5 V, T_A = 25°C

MM.	DADAMETER	TEST CONDITI	TEST CONDITIONS				
Wire	PARAMETER	TEST CONDITI					
00	NN 100 CON.	$R_L = 10 \text{ k}\Omega$, $C_L = 20 \text{ pF}$,	V _{IPP} = 1 V	3.6	Ohr.		
SR	Slew rate at unity gain	See Figure 1	V _{IPP} = 2.5 V	2.9	COM	V/μs	
V_n	Equivalent input noise voltage	$f = 1 \text{ kHz}, \qquad R_S = 20 \Omega,$	See Figure 2	25		nV/√Hz	
BOM	Maximum output-swing bandwidth	$V_O = V_{OH}$, $C_L = 20 pF$, See Figure 1	$R_L = 10 \text{ k}\Omega$,	320	Y.C.C	kHz	
B ₁	Unity-gain bandwidth	$V_{I} = 10 \text{ mV}, \qquad C_{L} = 20 \text{ pF},$	See Figure 3	1.7	A	MHz	
φm	Phase margin	$V_I = 10 \text{ mV}, \qquad f = B_1,$ See Figure 3	C _L = 20 pF,	46°	001.	OM	

operating characteristics, V_{DD} = 10 V, T_A = 25°C

	PARAMETER	TEST COM	TEST CONDITIONS			
	TANAMETER	TEST COI				
CD	Clausete et material de	$R_L = 10 \text{ k}\Omega$, $C_L = 20$	0 pF, VIPP = 1 V	5	.3	Sú.C
SR	Slew rate at unity gain	See Figure 1	V _{IPP} = 5.5 V	4	.6	V/μs
٧n	Equivalent input noise voltage	$f = 1 \text{ kHz}, \qquad R_S = 2$	0Ω , See Figure 2	2	25	nV/√Hz
ВОМ	Maximum output-swing bandwidth	$V_O = V_{OH}, C_L = 20$ See Figure 1	$0 pF$, $R_L = 10 kΩ$,	20	00	kHz
B ₁	Unity-gain bandwidth	$V_{I} = 10 \text{ mV}, C_{L} = 20 \text{ mV}$	0 pF, See Figure 3	2	.2	MHz
φm	Phase margin	$V_I = 10 \text{ mV}, f = B_1,$ See Figure 3	$C_L = 20 pF$,	49)°	W.10

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PARAMETER MEASUREMENT INFORMATION

single-supply versus split-supply test circuits

Because the TLC272 and TLC277 are optimized for single-supply operation, circuit configurations used for the various tests often present some inconvenience since the input signal, in many cases, must be offset from ground. This inconvenience can be avoided by testing the device with split supplies and the output load tied to the negative rail. A comparison of single-supply versus split-supply test circuits is shown below. The use of either circuit gives the same result.

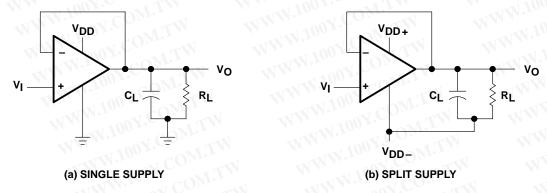


Figure 1. Unity-Gain Amplifier

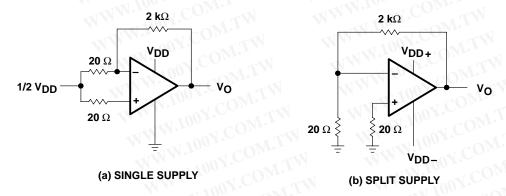


Figure 2. Noise-Test Circuit

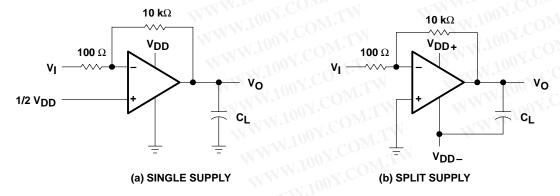


Figure 3. Gain-of-100 Inverting Amplifier



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PARAMETER MEASUREMENT INFORMATION

input bias current

Because of the high input impedance of the TLC272 and TLC277 operational amplifiers, attempts to measure the input bias current can result in erroneous readings. The bias current at normal room ambient temperature is typically less than 1 pA, a value that is easily exceeded by leakages on the test socket. Two suggestions are offered to avoid erroneous measurements:

- 1. Isolate the device from other potential leakage sources. Use a grounded shield around and between the device inputs (see Figure 4). Leakages that would otherwise flow to the inputs are shunted away.
- Compensate for the leakage of the test socket by actually performing an input bias current test (using a picoammeter) with no device in the test socket. The actual input bias current can then be calculated by subtracting the open-socket leakage readings from the readings obtained with a device in the test socket.

One word of caution: many automatic testers as well as some bench-top operational amplifier testers use the servo-loop technique with a resistor in series with the device input to measure the input bias current (the voltage drop across the series resistor is measured and the bias current is calculated). This method requires that a device be inserted into the test socket to obtain a correct reading; therefore, an open-socket reading is not feasible using this method.

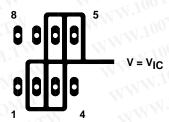


Figure 4. Isolation Metal Around Device Inputs (JG and P packages)

low-level output voltage

To obtain low-supply-voltage operation, some compromise was necessary in the input stage. This compromise results in the device low-level output being dependent on the common-mode input voltage level as well as the differential input voltage level. When attempting to correlate low-level output readings with those quoted in the electrical specifications, these two conditions should be observed. If conditions other than these are to be used, please refer to Figures 14 through 19 in the Typical Characteristics of this data sheet.

input offset voltage temperature coefficient

Erroneous readings often result from attempts to measure temperature coefficient of input offset voltage. This parameter is actually a calculation using input offset voltage measurements obtained at two different temperatures. When one (or both) of the temperatures is below freezing, moisture can collect on both the device and the test socket. This moisture results in leakage and contact resistance, which can cause erroneous input offset voltage readings. The isolation techniques previously mentioned have no effect on the leakage since the moisture also covers the isolation metal itself, thereby rendering it useless. It is suggested that these measurements be performed at temperatures above freezing to minimize error.



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PARAMETER MEASUREMENT INFORMATION

full-power response

Full-power response, the frequency above which the operational amplifier slew rate limits the output voltage swing, is often specified two ways: full-linear response and full-peak response. The full-linear response is generally measured by monitoring the distortion level of the output while increasing the frequency of a sinusoidal input signal until the maximum frequency is found above which the output contains significant distortion. The full-peak response is defined as the maximum output frequency, without regard to distortion, above which full peak-to-peak output swing cannot be maintained.

Because there is no industry-wide accepted value for significant distortion, the full-peak response is specified in this data sheet and is measured using the circuit of Figure 1. The initial setup involves the use of a sinusoidal input to determine the maximum peak-to-peak output of the device (the amplitude of the sinusoidal wave is increased until clipping occurs). The sinusoidal wave is then replaced with a square wave of the same amplitude. The frequency is then increased until the maximum peak-to-peak output can no longer be maintained (Figure 5). A square wave is used to allow a more accurate determination of the point at which the maximum peak-to-peak output is reached.

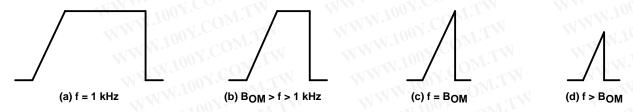


Figure 5. Full-Power-Response Output Signal

test time

Inadequate test time is a frequent problem, especially when testing CMOS devices in a high-volume, short-test-time environment. Internal capacitances are inherently higher in CMOS than in bipolar and BiFET devices and require longer test times than their bipolar and BiFET counterparts. The problem becomes more pronounced with reduced supply levels and lower temperatures.



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TYPICAL CHARACTERISTICS

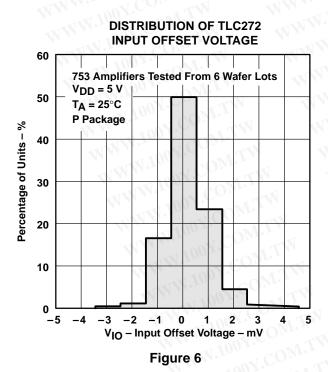
Table of Graphs

	COM.	OM. MAIN.	FIGUR
VIO	Input offset voltage	Distribution	6, 7
ανιο	Temperature coefficient of input offset voltage	Distribution	8, 9
Vон	High-level output voltage	vs High-level output current vs Supply voltage vs Free-air temperature	10, 11 12 13
VoL	Low-level output voltage	vs Common-mode input voltage vs Differential input voltage vs Free-air temperature vs Low-level output current	14, 15 16 17 18, 19
A _{VD}	Large-signal differential voltage amplification	vs Supply voltage vs Free-air temperature vs Frequency	20 21 32, 33
I _{IB}	Input bias current	vs Free-air temperature	22
lo V	Input offset current	vs Free-air temperature	22
VIC	Common-mode input voltage	vs Supply voltage	23
l _{DD}	Supply current	vs Supply voltage vs Free-air temperature	24 25
SR	Slew rate	vs Supply voltage vs Free-air temperature	26 27
	Normalized slew rate	vs Free-air temperature	28
V _{O(PP)}	Maximum peak-to-peak output voltage	vs Frequency	29
B ₁	Unity-gain bandwidth	vs Free-air temperature vs Supply voltage	30 31
φm	Phase margin	vs Supply voltage vs Free-air temperature vs Load capacitance	34 35 36
٧n	Equivalent input noise voltage	vs Frequency	37
	Phase shift	vs Frequency	32, 33

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TYPICAL CHARACTERISTICS



DISTRIBUTION OF TLC272 AND TLC277 INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT

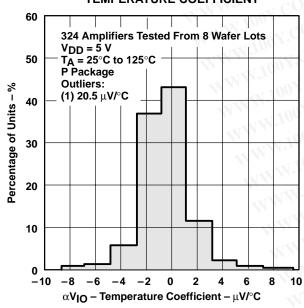


Figure 8

DISTRIBUTION OF TLC272 INPUT OFFSET VOLTAGE

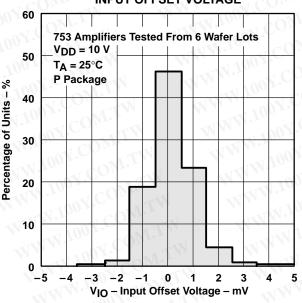


Figure 7

DISTRIBUTION OF TLC272 AND TLC277 INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT

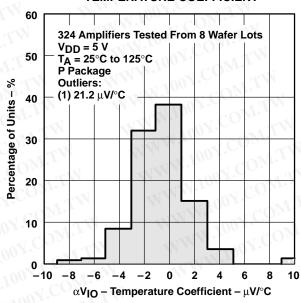
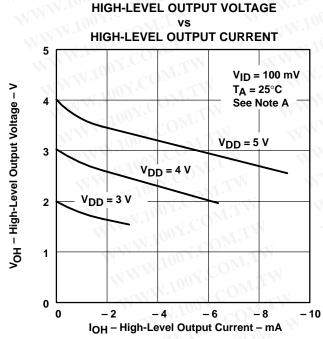


Figure 9

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TYPICAL CHARACTERISTICS†



NOTE A: The 3-V curve only applies to the C version.

Figure 10

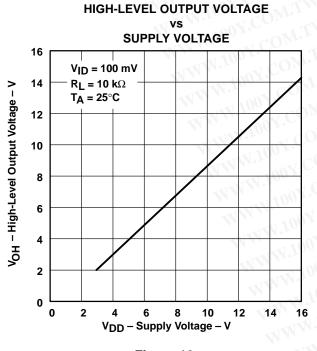


Figure 12

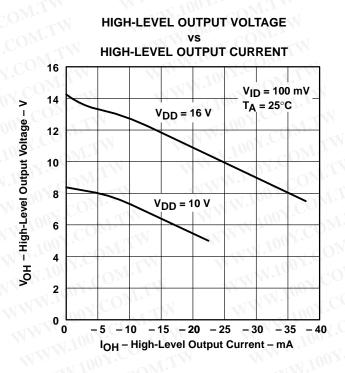


Figure 11

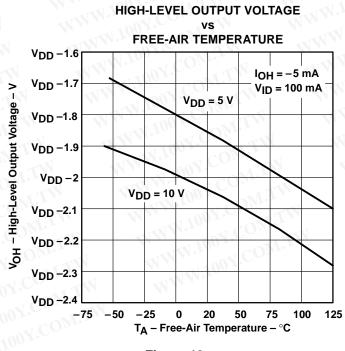


Figure 13

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

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TYPICAL CHARACTERISTICS[†]

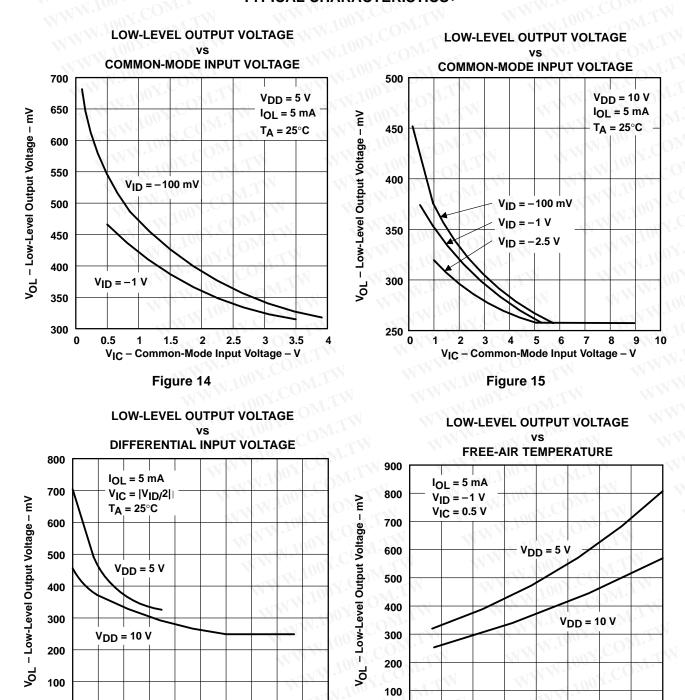


Figure 16

V_{ID} - Differential Input Voltage - V

-3 -4 -5 -6 -7 -8 -9 -10

† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



-75

-50

-25

25

T_A – Free-Air Temperature – °C

Figure 17

50

75

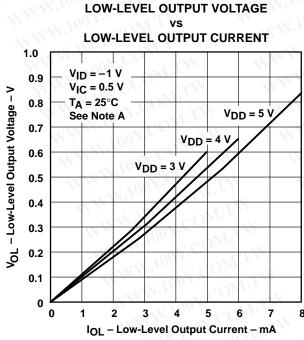
100

125

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LOW-LEVEL OUTPUT VOLTAGE

TYPICAL CHARACTERISTICS[†]



NOTE A: The 3-V curve only applies to the C version. Figure 18

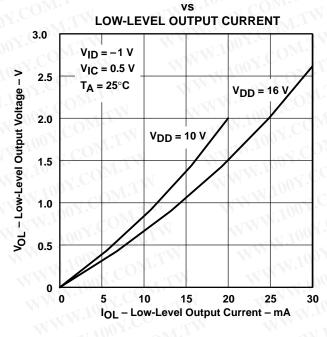
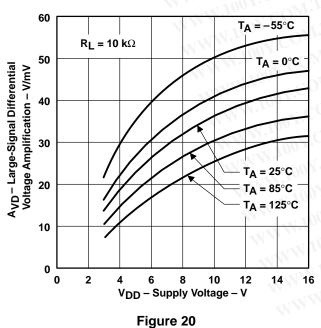


Figure 19





LARGE-SIGNAL **DIFFERENTIAL VOLTAGE AMPLIFICATION** FREE-AIR TEMPERATURE

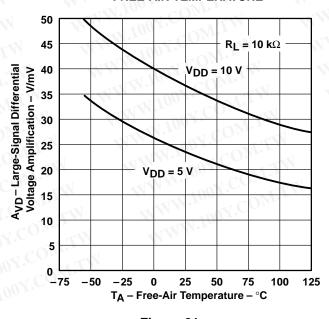


Figure 21

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

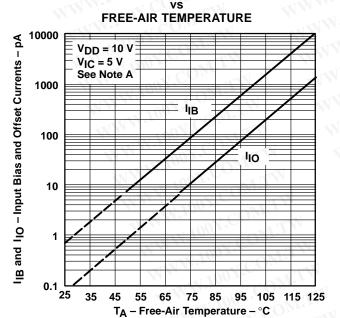


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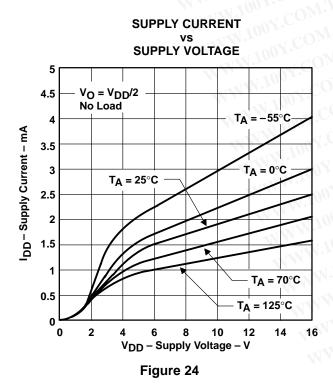
TYPICAL CHARACTERISTICS[†]

INPUT BIAS CURRENT AND INPUT OFFSET CURRENT



NOTE A: The typical values of input bias current and input offset current below 5 pA were determined mathematically.

Figure 22



COMMON-MODE INPUT VOLTAGE POSITIVE LIMIT VS

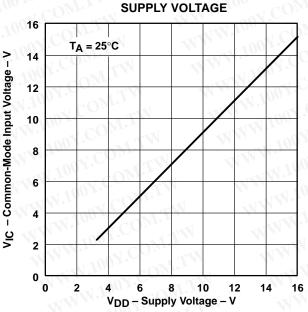


Figure 23

SUPPLY CURRENT vs FREE-AIR TEMPERATURE

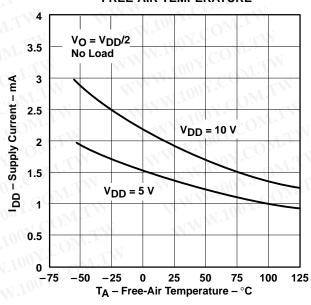


Figure 25

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



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TYPICAL CHARACTERISTICS[†]

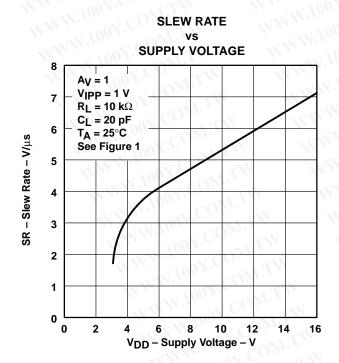
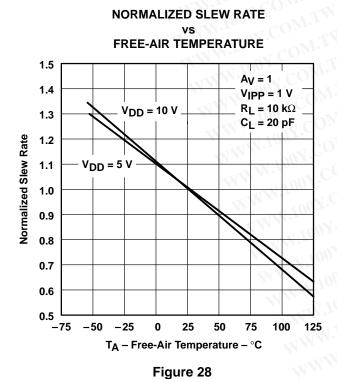
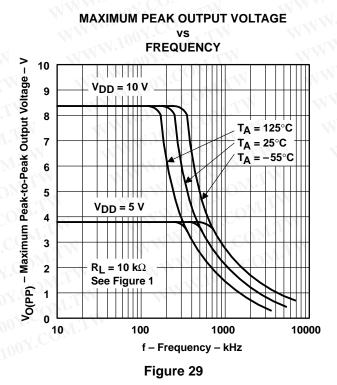


Figure 26



SLEW RATE vs FREE-AIR TEMPERATURE 8 $A_V = 1$ $R_L = 10 k\Omega$ 7 V_{DD} = 10 V $C_L = 20 pF$ V_{IPP} = 5.5 V See Figure 1 6 Rate - V/µs $V_{DD} = 10 V$ 5 $V_{IPP} = 1 V$ 4 - Slew 3 SR $V_{DD} = 5 V$ 2 $V_{IPP} = 1 V$ $V_{DD} = 5 V$ 1 V_{IPP} = 2.5 V 0 -75 -50-250 25 50 75 100 T_A - Free-Air Temperature - °C

Figure 27



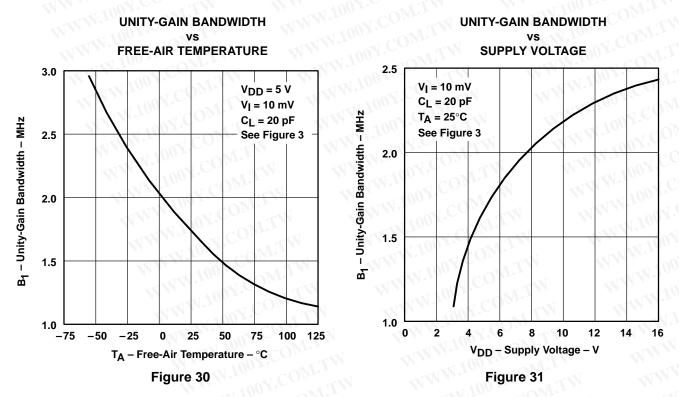
[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



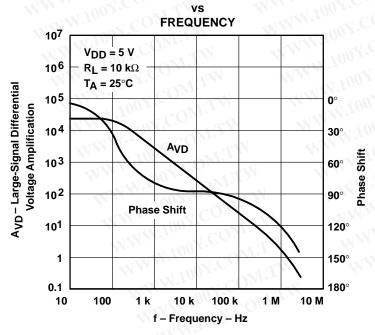
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TYPICAL CHARACTERISTICS[†]



LARGE-SIGNAL DIFFERENTIAL VOLTAGE **AMPLIFICATION AND PHASE SHIFT**



† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



Figure 32

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TYPICAL CHARACTERISTICS[†]

LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE SHIFT

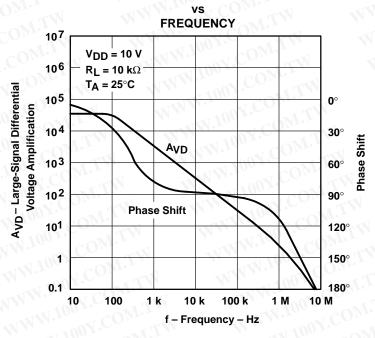
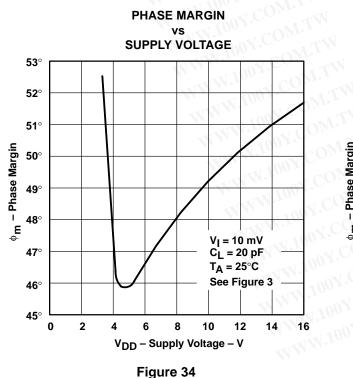


Figure 33



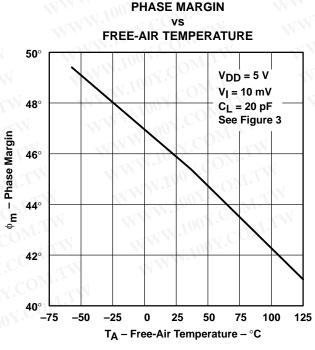


Figure 35

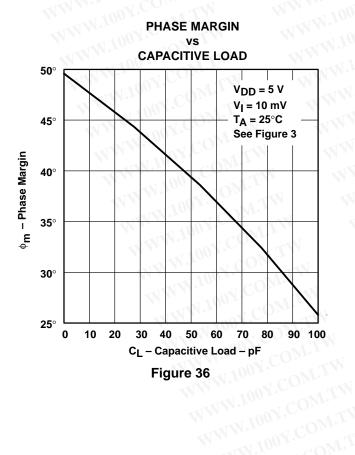
† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

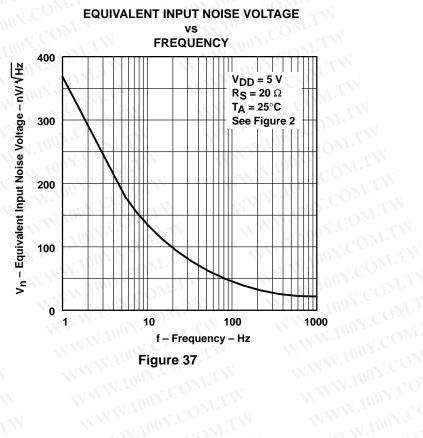


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TYPICAL CHARACTERISTICS





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APPLICATION INFORMATION

single-supply operation

While the TLC272 and TLC277 perform well using dual power supplies (also called balanced or split supplies), the design is optimized for single-supply operation. This design includes an input common-mode voltage range that encompasses ground as well as an output voltage range that pulls down to ground. The supply voltage range extends down to 3 V (C-suffix types), thus allowing operation with supply levels commonly available for TTL and HCMOS; however, for maximum dynamic range, 16-V single-supply operation is recommended.

Many single-supply applications require that a voltage be applied to one input to establish a reference level that is above ground. A resistive voltage divider is usually sufficient to establish this reference level (see Figure 38). The low input bias current of the TLC272 and TLC277 permits the use of very large resistive values to implement the voltage divider, thus minimizing power consumption.

The TLC272 and TLC277 work well in conjunction with digital logic; however, when powering both linear devices and digital logic from the same power supply, the following precautions are recommended:

- Power the linear devices from separate bypassed supply lines (see Figure 39); otherwise, the linear device supply rails can fluctuate due to voltage drops caused by high switching currents in the digital logic.
- 2. Use proper bypass techniques to reduce the probability of noise-induced errors. Single capacitive decoupling is often adequate; however, high-frequency applications may require RC decoupling.

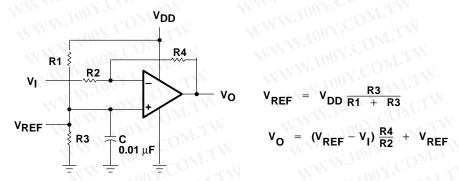
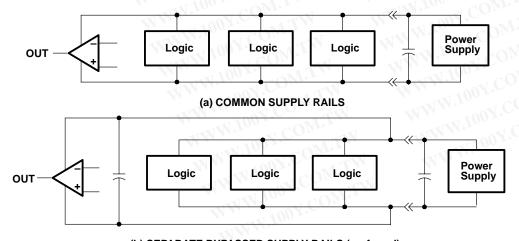


Figure 38. Inverting Amplifier With Voltage Reference



(b) SEPARATE BYPASSED SUPPLY RAILS (preferred)

Figure 39. Common vs Separate Supply Rails



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APPLICATION INFORMATION

input characteristics

The TLC272 and TLC277 are specified with a minimum and a maximum input voltage that, if exceeded at either input, could cause the device to malfunction. Exceeding this specified range is a common problem, especially in single-supply operation. Note that the lower range limit includes the negative rail, while the upper range limit is specified at $V_{DD}-1$ V at $T_A=25$ °C and at $V_{DD}-1.5$ V at all other temperatures.

The use of the polysilicon-gate process and the careful input circuit design gives the TLC272 and TLC277 very good input offset voltage drift characteristics relative to conventional metal-gate processes. Offset voltage drift in CMOS devices is highly influenced by threshold voltage shifts caused by polarization of the phosphorus dopant implanted in the oxide. Placing the phosphorus dopant in a conductor (such as a polysilicon gate) alleviates the polarization problem, thus reducing threshold voltage shifts by more than an order of magnitude. The offset voltage drift with time has been calculated to be typically 0.1 μ V/month, including the first month of operation.

Because of the extremely high input impedance and resulting low bias current requirements, the TLC272 and TLC277 are well suited for low-level signal processing; however, leakage currents on printed-circuit boards and sockets can easily exceed bias current requirements and cause a degradation in device performance. It is good practice to include guard rings around inputs (similar to those of Figure 4 in the Parameter Measurement Information section). These guards should be driven from a low-impedance source at the same voltage level as the common-mode input (see Figure 40).

Unused amplifiers should be connected as grounded unity-gain followers to avoid possible oscillation.

noise performance

The noise specifications in operational amplifier circuits are greatly dependent on the current in the first-stage differential amplifier. The low input bias current requirements of the TLC272 and TLC277 result in a very low noise current, which is insignificant in most applications. This feature makes the devices especially favorable over bipolar devices when using values of circuit impedance greater than 50 k Ω , since bipolar devices exhibit greater noise currents.

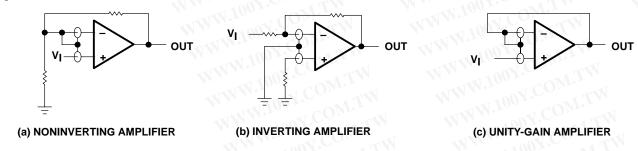


Figure 40. Guard-Ring Schemes

output characteristics

The output stage of the TLC272 and TLC277 is designed to sink and source relatively high amounts of current (see typical characteristics). If the output is subjected to a short-circuit condition, this high current capability can cause device damage under certain conditions. Output current capability increases with supply voltage.

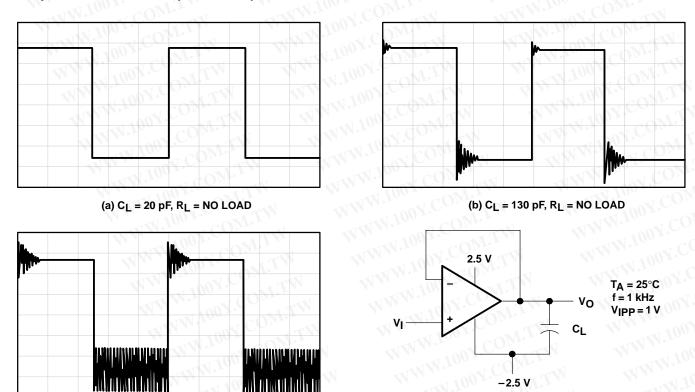
All operating characteristics of the TLC272 and TLC277 are measured using a 20-pF load. The devices can drive higher capacitive loads; however, as output load capacitance increases, the resulting response pole occurs at lower frequencies, thereby causing ringing, peaking, or even oscillation (see Figure 41). In many cases, adding a small amount of resistance in series with the load capacitance alleviates the problem.



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output characteristics (continued)



(c) $C_L = 150 \text{ pF}, R_L = NO \text{ LOAD}$

(d) TEST CIRCUIT

Figure 41. Effect of Capacitive Loads and Test Circuit

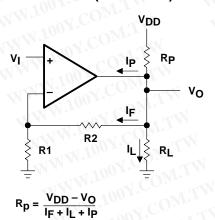
Although the TLC272 and TLC277 possess excellent high-level output voltage and current capability, methods for boosting this capability are available, if needed. The simplest method involves the use of a pullup resistor (Rp) connected from the output to the positive supply rail (see Figure 42). There are two disadvantages to the use of this circuit. First, the NMOS pulldown transistor N4 (see equivalent schematic) must sink a comparatively large amount of current. In this circuit, N4 behaves like a linear resistor with an on resistance between approximately 60 Ω and 180 Ω , depending on how hard the operational amplifier input is driven. With very low values of Rp, a voltage offset from 0 V at the output occurs. Second, pullup resistor Rp acts as a drain load to N4 and the gain of the operational amplifier is reduced at output voltage levels where N5 is not supplying the output current.

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APPLICATION INFORMATION

output characteristics (continued)



 I_p = Pullup current required by the operational amplifier (typically 500 μ A)

Figure 42. Resistive Pullup to Increase VOH

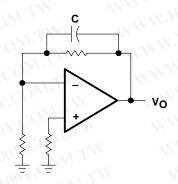


Figure 43. Compensation for Input Capacitance

feedback

Operational amplifier circuits almost always employ feedback, and since feedback is the first prerequisite for oscillation, some caution is appropriate. Most oscillation problems result from driving capacitive loads (discussed previously) and ignoring stray input capacitance. A small-value capacitor connected in parallel with the feedback resistor is an effective remedy (see Figure 43). The value of this capacitor is optimized empirically.

electrostatic discharge protection

The TLC272 and TLC277 incorporate an internal electrostatic discharge (ESD) protection circuit that prevents functional failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.2. Care should be exercised, however, when handling these devices as exposure to ESD may result in the degradation of the device parametric performance. The protection circuit also causes the input bias currents to be temperature dependent and have the characteristics of a reverse-biased diode.

latch-up

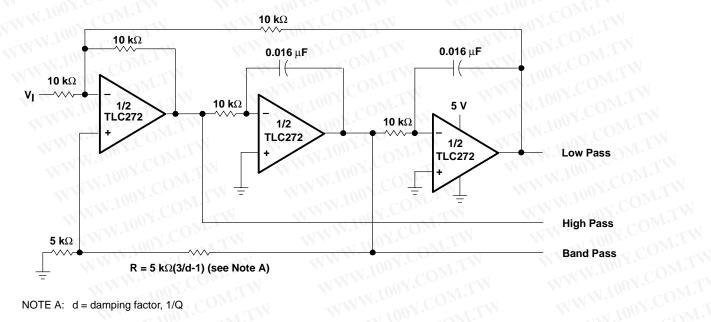
Because CMOS devices are susceptible to latch-up due to their inherent parasitic thyristors, the TLC272 and TLC277 inputs and outputs were designed to withstand -100-mA surge currents without sustaining latch-up; however, techniques should be used to reduce the chance of latch-up whenever possible. Internal protection diodes should not, by design, be forward biased. Applied input and output voltage should not exceed the supply voltage by more than 300 mV. Care should be exercised when using capacitive coupling on pulse generators. Supply transients should be shunted by the use of decoupling capacitors (0.1 μ F typical) located across the supply rails as close to the device as possible.

The current path established if latch-up occurs is usually between the positive supply rail and ground and can be triggered by surges on the supply lines and/or voltages on either the output or inputs that exceed the supply voltage. Once latch-up occurs, the current flow is limited only by the impedance of the power supply and the forward resistance of the parasitic thyristor and usually results in the destruction of the device. The chance of latch-up occurring increases with increasing temperature and supply voltages.



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NOTE A: d = damping factor, 1/Q

Figure 44. State-Variable Filter

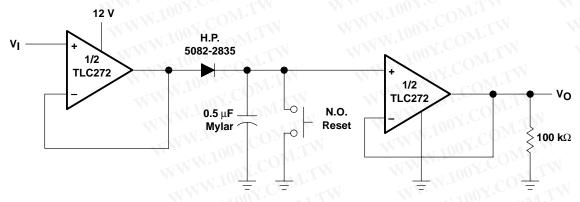
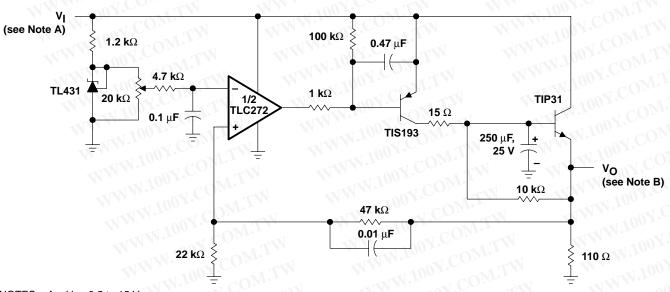


Figure 45. Positive-Peak Detector

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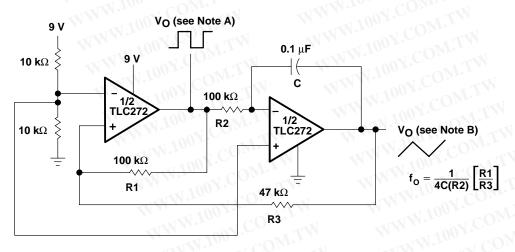
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NOTES: A. $V_I = 3.5 \text{ to } 15 \text{ V}$ B. $V_O = 2 \text{ V}$, 0 to 1 A

Figure 46. Logic-Array Power Supply



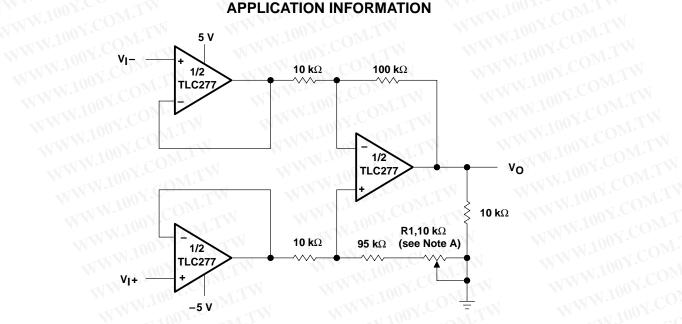
NOTES: A. $V_{O(PP)} = 8 \text{ V}$ B. $V_{O(PP)} = 4 \text{ V}$

Figure 47. Single-Supply Function Generator



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NOTE B: CMRR adjustment must be noninductive.

Figure 48. Low-Power Instrumentation Amplifier

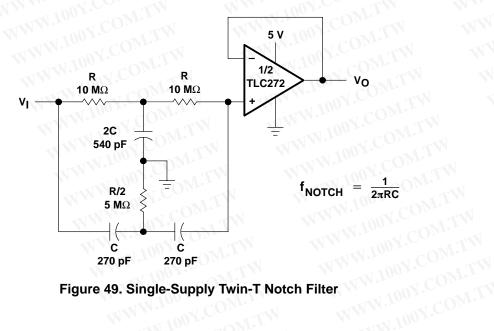


Figure 49. Single-Supply Twin-T Notch Filter



PACKAGE OPTION ADDENDUM

17-May-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
5962-89494022A	OBSOLETE	LCCC	FK	20	COM	TBD	Call TI	Call TI
TLC272ACD	ACTIVE	SOIC	D	8	75	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC272ACDR	ACTIVE	SOIC	D	8	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC272ACP	ACTIVE	PDIP	Р	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272ACPE4	ACTIVE	PDIP	Р	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272ACPSR	ACTIVE	SO	PS	8	2000	TBD	CU NIPDAU	Level-1-220C-UNLIM
TLC272AID	ACTIVE	SOIC	D	8	75	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC272AIDR	ACTIVE	SOIC	D	8	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC272AIP	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272AIPE4	ACTIVE	PDIP	TWP	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272BCD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC272BCDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC272BCDRG4	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC272BCP	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272BCPE4	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272BCPSR	ACTIVE	so	PS	8	2000	Pb-Free (RoHS)	Call TI	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC272BID	ACTIVE	SOIC	DO.	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC272BIDR	ACTIVE	SOIC	100 D.CO	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC272BIP	ACTIVE	PDIP	10(P)	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272BIPE4	ACTIVE	PDIP	V.1P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272CD	ACTIVE	SOIC	11.D	V. (8)	75	Pb-Free (RoHS)		Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC272CDR	ACTIVE	SOIC	D 10	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC272CP	ACTIVE	PDIP	P . 1	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272CPE4	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272CPSR	ACTIVE	SO	PS	8	2000	TBD	CU NIPDAU	Level-1-220C-UNLIM
TLC272CPSRG4	ACTIVE	SO	PS	8	2000	TBD	CU NIPDAU	Level-1-220C-UNLIM
TLC272CPW	ACTIVE	TSSOP	PW	8	150	TBD	CU NIPDAU	Level-1-220C-UNLIM



PACKAGE OPTION ADDENDUM

17-May-2005

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TLC272CPWLE	OBSOLETE	TSSOP	PW	8	$O_{M^{*,r}}$	TBD	Call TI	Call TI
TLC272CPWR	ACTIVE	TSSOP	PW	8	2000	TBD	CU NIPDAU	Level-1-220C-UNLIM
TLC272CPWRG4	ACTIVE	TSSOP	PW	008.	2000	Green (RoHS & no Sb/Br)	Call TI	Level-1-260C-UNLIM
TLC272ID	ACTIVE	SOIC	D	8	75	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC272IDR	ACTIVE	SOIC	D	8	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC272IP	ACTIVE	PDIP	P	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272IPE4	ACTIVE	PDIP	Р	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC272IPW	ACTIVE	TSSOP	PW	8	150	TBD	Call TI	Level-1-220C-UNLIM
TLC272MFKB	OBSOLETE	LCCC	FK ◀	20	100	TBD	Call TI	Call TI
TLC272MJG	OBSOLETE	CDIP	JG	8	M.To	TBD	Call TI	Call TI
TLC272MJGB	OBSOLETE	CDIP	JG	8	MW.10	TBD	Call TI	Call TI
TLC272P-M	PREVIEW	PDIP	P	8	WW.1	Pb-Free (RoHS)	Call TI	Level-NA-NA-NA
TLC277CD	ACTIVE	SOIC	D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC277CDR	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC277CDRG4	ACTIVE	SOIC	DW	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC277CP	ACTIVE	PDIP	ONPITY	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC277CPE4	ACTIVE	PDIP	COBI	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC277CPSR	ACTIVE	so	PS	8	2000	Pb-Free (RoHS)	Call TI	Level-2-260C-1YEAR/ Level-1-220C-UNLIM
TLC277ID	ACTIVE	SOIC	Y.C	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC277IDG4	ACTIVE	SOIC	O D	8	75	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC277IDR	ACTIVE	SOIC	TOO D. C.	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC277IP	ACTIVE	PDIP	P 7.00	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC277IPE4	ACTIVE	PDIP	Pooy	8	50	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
TLC277MFKB	OBSOLETE	LCCC	FK	20	T.Mr	TBD	Call TI	Call TI
TLC277MJG	OBSOLETE	CDIP	JG	8	J. C. T.	√ TBD √	Call TI	Call TI
TLC277MJGB	OBSOLETE	CDIP	JG	8	OM	TBD	Call TI	Call TI

(1) The marketing status values are defined as follows: **ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.



PACKAGE OPTION ADDENDUM

17-May-2005

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS) or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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